

RL78/G14, H8/36109

Migration Guide from H8 to RL78: Timer B1

Introduction

This application note describes how to migrate the timer B1 of the H8/36109 to the timer array unit (TAU) of the RL78/G14 (100-pin package).

Target Device

RL78/G14, H8/36109

When using this application note with other Renesas MCUs, careful evaluation is recommended after making modifications to comply with the alternate MCU.

Contents

1.	Functions of Timer B1 of H8/36109 and Timer Array Unit of RL78/G14	3
2.	Summary of Differences between Functions	6
2.1	Differences between Interval timer operation and Auto-reload timer operation	7
2.2	Differences between event counter operation	8
3.	Comparison between Registers	9
4.	Sample Code for Timer Array Unit	11
5.	Documents for Reference	11
Rev	rision History	12

1. Functions of Timer B1 of H8/36109 and Timer Array Unit of RL78/G14

Table 1.1 shows the functions of the timer B1 of H8/36109, and Table 1.2 shows the functions of the timer array unit (TAU) of RL78/G14.

Table 1.1 Functions of timer B1

Table III Tallouelle et alline 21			
Function	Explanation		
Interval timer operation	Timer B1 functions as an 8-bit interval timer. Upon reset, TCB1 is cleared to H'00 and bit TMB17 is cleared to 0, so up-counting and interval timing resume immediately.		
Auto-reload timer operation	Timer B1 functions as an 8-bit auto-reload timer. After the count value in TCB1 reaches H'FF, the next clock signal input causes timer B1 to overflow. The TLB1 value is then loaded into TCB1, and the count continues from that value.		
Event counter operation	Timer B1 can operate as an event counter in which TMIB1 is set to an event input pin. External event counting is selected by setting bits TMB12 to TMB10 in TMB1 to 1.		

Table 1.2 Functions of Timer Array Unit

Function	Explanation	
Interval timer	Each timer of a unit can be used as a reference timer that generates an interrupt (INTTMmn) at fixed intervals.	
Square wave output	A toggle operation is performed each time INTTMmn interrupt is generated and a square wave with a duty factor of 50% is output from a timer output pin (TOmn).	
External event counter	Each timer of a unit can be used as an event counter that generates an interrupt when the number of the valid edges of a signal input to the timer input pin (Tlmn) has reached a specific value.	
Divider	A clock input from a timer input pin (TI00) is divided and output from an output pin (TO00).	
Input pulse interval measurement	Counting is started by the valid edge of a pulse signal input to a timer input pin (Tlmn). The count value of the timer is captured at the valid edge of the next pulse. In this way, the interval of the input pulse can be measured.	
Measurement of high-/low-level width of input signal	Counting is started by a single edge of the signal input to the timer input pin (Tlmn), and the count value is captured at the other edge. In this way, the high-level or low-level width of the input signal can be measured.	
Delay counter	Counting is started at the valid edge of the signal input to the timer input pin (Tlmn), and an interrupt is generated after any delay period.	
One-shot pulse output	Two channels are used as a set to generate a one-shot pulse with a specified output timing and a specified pulse width.	
PWM output	Two channels are used as a set to generate a pulse with a specified period and a specified duty factor.	
Multiple PWM output	By extending the PWM function and using one master channel and two or more slave channels, up to seven types of PWM signals that have a specific period and a specified duty factor can be generated.	

Timer B1 of the H8 / 36109 is an 8-bit timer. This timer has interval timer operation, auto-reload timer operation, and event counter operation. This timer can select seven internal clock sources or an external clock. An interrupt is generated when the counter overflows.

Figure 1.1 shows a block diagram of the timer B1.

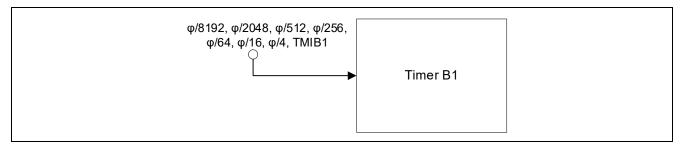


Figure 1.1 Block diagram of the timer B1

The timer array unit (TAU) incorporated in the RL78/G14 has four 16-bit timers. Each 16-bit timer is called a channel and can be used as an independent timer. In addition, two or more channels can be combined to serve as a higher-accuracy timer.

Each channel has one timer counter register, one timer data register, one input pin, and one output pin.

Figure 1.2 shows a block diagram of the timer array unit (TAU).

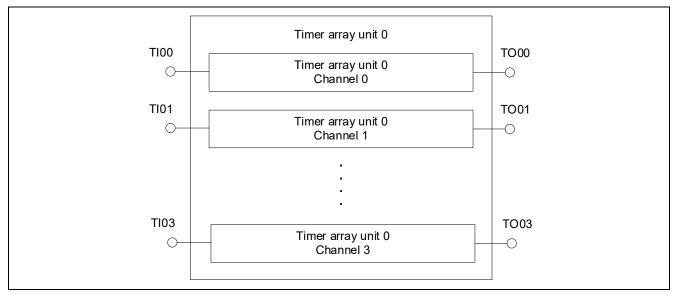


Figure 1.2 Block Diagram of Timer Array Unit

Table 1.3 shows the TAU functions corresponding to the timer B1.

Table 1.3 Correspondence between Functions

H8/36109	RL78/G14
Timer B1	Timer Array Unit (TAU)
Interval timer operation	Interval timer
Auto-reload timer operation	
Event counter operation	External event counter

The timer array unit (TAU) can implement the functions equivalent to those provided in the timer B1 by using each channel independently or a combination of multiple channels simultaneously.

The interval timer operation and auto-reload timer operation of the timer B1 correspond to the interval timer function of the TAU.

The event counter operation of the timer B1 correspond to the external event counter function of the TAU.

2. Summary of Differences between Functions

Table 2.1 summarizes the differences between the functions of timer B1 and TAU.

Table 2.1 Summary of Differences between Functions

Item	H8/36109	RL78/G14
	Timer B1	Timer Array Unit (TAU)
Count clock	φ/4, φ/16, φ/64, φ/256, φ/512, φ/2048, φ/8192, TMIB1 ^(Note1)	fτclκ (fclκ, to fclκ/2 ¹⁵), fsub(Note 2), fil(Note 2)
Operation Mode	- Interval Timer Operation - Auto-Reload Timer Operation - Event Counter Operation	 Interval timer Square wave output External event counter Frequency divider Input pulse interval measurement Input signal high-/low-level width measurement Delay counter One-shot pulse output function PWM output Multiple PWM output
Operation after reset release	Interval timer operation and counting up	Stop
Input pin of count clock	P15 / TMIB1	Unit 0: P00 / T100, P16 / T101 / T001 P17 / T102 / T002, P31 / T103 / T003 Unit 1: T110 / T010 / P64, T111 / T011 / P65 T112 / T012 / P66, T113 / T013 / P67
Interrupt source	Overflow	Compare match / Input capture, Overflow, Underflow

Note1. External event (TMIB1): rising or falling edge

Note2. Channel 1 only

2.1 Differences between Interval timer operation and Auto-reload timer operation

The interval timer operation and auto-reload timer operation of timer B1 of the H8/36109 correspond to the interval timer of the TAU of the RL78/G14. Table 2.2 shows the differences between the interval timer operation and auto-reload timer operation

Table 2.2 Differences between the interval timer operation and auto-reload timer operation

Item	H8/36109	RL78/G14
	Timer B1	Timer Array Unit (TAU)
	Interval timer operation	Interval timer
	Auto-reload timer operation	
Control of timer B1	Setting the MSTTB1 bit in the MSTCR2	Setting the TAU1EN ^(Note1) bit or TAU0EN bit
input clock supply	register to 0 (Initial value)	in the PER0 register to 1
Count clock	φ/4, φ/16, φ/64, φ/256, φ/512, φ/2048, φ/8192, TMIB1 ^(Note2)	ftclk (fclk, ~ fclk/2 ¹⁵), fsub (Note3), fil (Note3)
Count mode	- Count up	- Count down
	- TMB17 bit in TMB1	The TCRmn register is loaded with the
	setting to 0:	TDRmn register value at the next count
	Repeats counting from H'00 to H'FF.	clock after TCRmn = 0000H.
	setting to 1:	
	Repeats counting from the TLB1 register	
	setting value to H'FF.	
Count start condition	- Reset release	Setting the TSmn bit in the TSm register to
	- Setting a value to the TLB1 register	1
	- Setting the TMB17 bit in the TMB1 register	
	to 1 (Auto-reload timer operation)	
Count stop condition	None	Setting the TTmn bit in the TTm register to 1
Interrupt request	TCB1 register overflow	- When TCRmn reaches 0000H and then
generation timing		the next count clock pulse is generated
		- When count operation starts (only if
		MDmn0 bit in the TMRmn register is set to
		1)
Acquire timer counter	Reading the TCB1 register	Reading the TCRmn register
value		
Write timer counter value	None (Writing the TLB1 register)	None (Writing the TDRmn register)
Counter reload	- TCB1 register overflow	- When TCRmn reaches 0000H and then
	- Writing the TLB1 register	the next count clock pulse is generated

Note1. 80 and 100-pin products only.

Note2. External event (TMIB1): rising or falling edge

Note3. Channel 1 only

2.2 Differences between event counter operation

The event counter operation of timer B1 of the H8/36109 correspond to the external event counter of the TAU of the RL78/G14. Table 2.3 shows the differences between the event counter operation.

Table 2.3 Differences between the event counter operation

Item H8/36109		RL78/G14	
Timer B1		Timer Array Unit (TAU)	
	event counter operation	External event counter	
Control of timer B1	Setting the MSTTB1 bit in the MSTCR2	Setting the TAU1EN ^(Note1) bit or TAU0EN bit	
input clock supply	register to 0 (Initial value)	in the PER0 register to 1	
Count clock TMIB1 (Note2)		Tlmn pin input valid edge	
Count mode	Count up	Count down	
Count start condition	TMB1 register	Setting the TSmn bit in the TSm register to	
	Setting the TMB12 to TMB10 bits to B'111	1	
	and then inputting the rising or falling edge		
	of the TMB1 input pin.		
Count stop condition	None	Setting the TTmn bit in the TTm register to 1	
Interrupt request	TCB1 register overflow	When the valid edge on the TImn pin is	
generation timing		detected for the times indicated by (set	
		value of TDRmn register + 1)	
Acquire timer counter	Reading the TCB1 register	Reading the TCRmn register	
value			
Write timer counter None (Writing the TLB1 register)		None	
value			

Note1. 80 and 100-pin products only.

Note2. External event (TMIB1): rising or falling edge

3. Comparison between Registers

Table 3.1 and Table 3.2 compares the registers for the H8/36109 Timer B1 and the registers for the RL78/G14 Timer Array Unit.

Table 3.1 Comparison between Registers (1/2)

Item	H8/36109	RL78/G14
	Timer B1	Timer Array Unit (TAU)
Control of timer B1 input clock	MSTCR2 register	None
supply	MSTTB1 bit	
Control of timer array unit input	None	PER0 register
clock		TAU1EN bit (Note), TAU0EN bit
Auto-reload function select	TMB1 register	None
	TMB17 bit	
Clock select	TMB1 register	TPSm register
	TMB12 - TMB10 bit	TMRmn register
		CKSmn1 bit, CKSmn0 bit
Timer counter	TCB1 register	TCRmn register
Timer load register	TLB1 register	TDRmn register
Selection of count clock (f _{TCLK}) of	None	TMRmn register
channel n		CCSmn bit
Selection between using channel	None	TMRmn register
n independently or simultaneously		MASTERmn bit
with another channel (as a slave		
or master)		
Selection of 8 or 16-bit timer	None	TMRmn register
operation for channels 1 and 3		SPLITmn bit
Setting of start trigger or capture	None	TMRmn register
trigger of channel n		STSmn2 - STSmn0 bit
Selection of TImn pin input valid	None	TMRmn register
edge		CISmn1 bit, CISmn0 bit
Operation mode of channel n	None	TMRmn register
		MDmn3 - MDmn1 bit
Setting of starting counting and	None	TMRmn register
interrupt		MDmn0 bit
Counter overflow status of	None	TSRmn register
channel n		OVF bit
Indication of operation enable/stop	None	TEm register
status of channel n		TEmn bit
Operation enable (start) trigger of	None	TSm register
channel n		TSmn bit
Operation stop trigger of channel	None	TTm register
n		TTmn bit

Note. 80 and 100-pin products only.

Table 3.2 Comparison between Registers (2/2)

Selection of timer input used with channel 0	None	TIS0 register TIS04 bit
Selection of timer input used with channel 1	None	TIS0 register TIS02 - TIS00 bit
Timer output enable/disable of channel n	None	TOEm register TOEm3 - TOEm0 bit
Timer output of channel n	None	TOm register TOmn bit
Control of timer output level of channel n	None	TOLm register TOLmn bit
Control of timer output mode of channel n	None	TOMm register TOmn bit
Input switch control register	None	ISC register SSIE00 bit ISC1 bit, ISC0 bit
Noise filter enable register	None	NFEN1 register, NFEN2 register

4. Sample Code for Timer Array Unit

The sample code for the timer Array Unit is explained in the following application notes.

RL78/G13 Timer Array Unit (Interval Timer) CC-RL (R01AN2576)

5. Documents for Reference

User's Manual:

- RL78/G14 User's Manual: Hardware (R01UH0186)
- H8/36109 Group User's Manual: Hardware (R01UH0294)

The latest versions can be downloaded from the Renesas Electronics website.

Technical Update/Technical News:

The latest information can be downloaded from the Renesas Electronics website.

Revision History

		Description	
Rev.	Date	Page	Summary
1.00	Feb. 25, 2020	-	First edition issued

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Precaution against Electrostatic Discharge (ESD)

A strong electrical field, when exposed to a CMOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop the generation of static electricity as much as possible, and quickly dissipate it when it occurs. Environmental control must be adequate. When it is dry, a humidifier should be used. This is recommended to avoid using insulators that can easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors must be grounded. The operator must also be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions must be taken for printed circuit boards with mounted semiconductor devices.

2. Processing at power-on

The state of the product is undefined at the time when power is supplied. The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the time when power is supplied. In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the time when power is supplied until the reset process is completed. In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the time when power is supplied until the power reaches the level at which resetting is specified.

3. Input of signal during power-off state

Do not input signals or an I/O pull-up power supply while the device is powered off. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Follow the guideline for input signal during power-off state as described in your product documentation.

4. Handling of unused pins

Handle unused pins in accordance with the directions given under handling of unused pins in the manual. The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of the LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible.

5. Clock signals

After applying a reset, only release the reset line after the operating clock signal becomes stable. When switching the clock signal during program execution, wait until the target clock signal is stabilized. When the clock signal is generated with an external resonator or from an external oscillator during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Additionally, when switching to a clock signal produced with an external resonator or by an external oscillator while program execution is in progress, wait until the target clock signal is stable.

- 6. Voltage application waveform at input pin
 - Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (Max.) and V_{IH} (Min.) due to noise, for example, the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (Max.) and V_{IH} (Min.).
- 7. Prohibition of access to reserved addresses

Access to reserved addresses is prohibited. The reserved addresses are provided for possible future expansion of functions. Do not access these addresses as the correct operation of the LSI is not guaranteed.

8. Differences between products

Before changing from one product to another, for example to a product with a different part number, confirm that the change will not lead to problems. The characteristics of a microprocessing unit or microcontroller unit products in the same group but having a different part number might differ in terms of internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

Notice

- 1. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation or any other use of the circuits, software, and information in the design of your product or system. Renesas Electronics disclaims any and all liability for any losses and damages incurred by you or third parties arising from the use of these circuits, software, or information.
- 2. Renesas Electronics hereby expressly disclaims any warranties against and liability for infringement or any other claims involving patents, copyrights, or other intellectual property rights of third parties, by or arising from the use of Renesas Electronics products or technical information described in this document, including but not limited to, the product data, drawings, charts, programs, algorithms, and application examples.
- 3. No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights of Renesas Electronics or others
- 4. You shall be responsible for determining what licenses are required from any third parties, and obtaining such licenses for the lawful import, export, manufacture, sales, utilization, distribution or other disposal of any products incorporating Renesas Electronics products, if required.
- 5. You shall not alter, modify, copy, or reverse engineer any Renesas Electronics product, whether in whole or in part. Renesas Electronics disclaims any and all liability for any losses or damages incurred by you or third parties arising from such alteration, modification, copying or reverse engineering.
- 6. Renesas Electronics products are classified according to the following two quality grades: "Standard" and "High Quality". The intended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below.
 - "Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; industrial robots; etc.
 - "High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control (traffic lights); large-scale communication equipment; key financial terminal systems; safety control equipment; etc.

Unless expressly designated as a high reliability product or a product for harsh environments in a Renesas Electronics data sheet or other Renesas Electronics document, Renesas Electronics products are not intended or authorized for use in products or systems that may pose a direct threat to human life or bodily injury (artificial life support devices or systems; surgical implantations; etc.), or may cause serious property damage (space system; undersea repeaters; nuclear power control systems; aircraft control systems; key plant systems; military equipment; etc.). Renesas Electronics disclaims any and all liability for any damages or losses incurred by you or any third parties arising from the use of any Renesas Electronics product that is inconsistent with any Renesas Electronics data sheet, user's manual or other Renesas Electronics document.

- 7. No semiconductor product is absolutely secure. Notwithstanding any security measures or features that may be implemented in Renesas Electronics hardware or software products, Renesas Electronics shall have absolutely no liability arising out of any vulnerability or security breach, including but not limited to any unauthorized access to or use of a Renesas Electronics product or a system that uses a Renesas Electronics product. RENESAS ELECTRONICS DOES NOT WARRANT OR GUARANTEE THAT RENESAS ELECTRONICS PRODUCTS, OR ANY SYSTEMS CREATED USING RENESAS ELECTRONICS PRODUCTS WILL BE INVULNERABLE OR FREE FROM CORRUPTION, ATTACK, VIRUSES, INTERFERENCE, HACKING, DATA LOSS OR THEFT, OR OTHER SECURITY INTRUSION ("Vulnerability Issues"). RENESAS ELECTRONICS DISCLAIMS ANY AND ALL RESPONSIBILITY OR LIABILITY ARISING FROM OR RELATED TO ANY VULNERABILITY ISSUES. FURTHERMORE, TO THE EXTENT PERMITTED BY APPLICABLE LAW, RENESAS ELECTRONICS DISCLAIMS ANY AND ALL WARRANTIES, EXPRESS OR IMPLIED, WITH RESPECT TO THIS DOCUMENT AND ANY RELATED OR ACCOMPANYING SOFTWARE OR HARDWARE, INCLUDING BUT NOT LIMITED TO THE IMPLIED WARRANTIES OF MERCHANTABILITY, OR FITNESS FOR A PARTICULAR PURPOSE.
- 8. When using Renesas Electronics products, refer to the latest product information (data sheets, user's manuals, application notes, "General Notes for Handling and Using Semiconductor Devices" in the reliability handbook, etc.), and ensure that usage conditions are within the ranges specified by Renesas Electronics with respect to maximum ratings, operating power supply voltage range, heat dissipation characteristics, installation, etc. Renesas Electronics disclaims any and all liability for any malfunctions, failure or accident arising out of the use of Renesas Electronics products outside of such specified ranges.
- 9. Although Renesas Electronics endeavors to improve the quality and reliability of Renesas Electronics products, semiconductor products have specific characteristics, such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Unless designated as a high reliability product or a product for harsh environments in a Renesas Electronics data sheet or other Renesas Electronics document, Renesas Electronics products are not subject to radiation resistance design. You are responsible for implementing safety measures to guard against the possibility of bodily injury, injury or damage caused by fire, and/or danger to the public in the event of a failure or malfunction of Renesas Electronics products, such as safety design for hardware and software, including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult and impractical, you are responsible for evaluating the safety of the final products or systems manufactured by you.
- 10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. You are responsible for carefully and sufficiently investigating applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive, and using Renesas Electronics products in compliance with all these applicable laws and regulations. Renesas Electronics disclaims any and all liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
- 11. Renesas Electronics products and technologies shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations. You shall comply with any applicable export control laws and regulations promulgated and administered by the governments of any countries asserting jurisdiction over the parties or transactions.
- 12. It is the responsibility of the buyer or distributor of Renesas Electronics products, or any other party who distributes, disposes of, or otherwise sells or transfers the product to a third party, to notify such third party in advance of the contents and conditions set forth in this document.
- 13. This document shall not be reprinted, reproduced or duplicated in any form, in whole or in part, without prior written consent of Renesas Electronics.
- 14. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products.
- (Note1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its directly or indirectly controlled subsidiaries.
- (Note2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.

(Rev.5.0-1 October 2020)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu, Koto-ku, Tokyo 135-0061, Japan www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit: www.renesas.com/contact/.